

### PolyZen olymer Enhanced Zener Die

Polymer Enhanced Zener Diode Micro-Assemblies

PRODUCT: ZEN098V130A24LS

DOCUMENT: SCD27645 REV LETTER: D

**REV DATE:** JULY 26,2016 **PAGE NO.: 1 OF 7** 

### **Specification Status: Preliminary**



#### **GENERAL DESCRIPTION**

Littelfuse PolyZen devices are polymer enhanced, precision Zener diode microassemblies. They offer resettable protection against multi-Watt fault events without the need for multi-Watt heat sinks.

The Zener diode used for voltage clamping in a PolyZen micro-assembly is selected due to its relatively flat voltage versus

current response. This helps improve output voltage clamping, even when input voltage is high and diode current is large.

An advanced feature of the PolyZen micro-assembly is that the Zener diode is thermally coupled to a resistively non-linear, polymer PTC (positive temperature coefficient) layer. This PTC layer is fully integrated into the device, and is electrically in series between  $V_{\text{IN}}$  and the diode clamped  $V_{\text{OUT}}$ .

This advanced PTC layer responds to either extended diode heating or overcurrent events by transitioning from a low to high resistance state, also known as "tripping". A tripped PTC will limit current and generate voltage drop. It helps to protect both the Zener diode and the follow-on electronics and effectively increases the diode's power handling capability.

The polymer enhanced Zener diode helps protect sensitive portable electronics from damage caused by inductive voltage spikes, voltage transients, incorrect power supplies and reverse bias. These devices are particularly suitable for portable electronics and other low-power DC devices.

#### **BENEFITS**

- Stable Zener diode helps shield downstream electronics from overvoltage and reverse bias
- Trip events shut out overvoltage and reverse bias sources
- Analog nature of trip events minimizes upstream inductive spikes
- Minimal power dissipation requiremen
- Single component placement

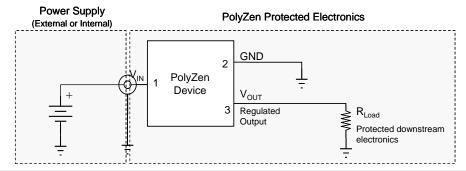
#### **FEATURES**

- Overvoltage transient suppression
- Stable Vz versus fault current
- Time delayed, overvoltage trip
- Time delayed, reverse bias trip
- Multi-Watt power handling capability
- Integrated device construction
- RoHS Compliant

#### **TARGET APPLICATIONS**

- DC power port protection in portable electronics
- DC power port protection for systems using
  - barrel jacks for power input
- Internal overvoltage & transient suppression
- DC output voltage regulation

#### TYPICAL APPLICATION BLOCK DIAGRAM





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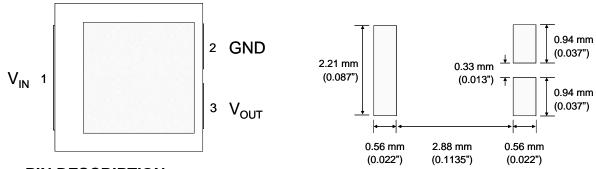
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#### **CONFIGURATION INFORMATION**

#### Pin Configuration (Top View)

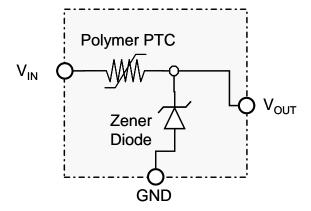
#### Pad Dimensions



#### **PIN DESCRIPTION**

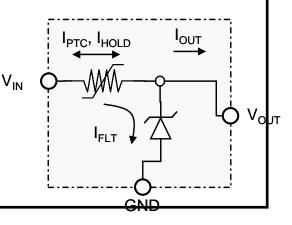
Pin	Pin	Pin Function	
Number	Name		
1	VIN	V <sub>IN</sub> . Protected input to Zener diode.	
2	GND	GND	
3	Vouт	V <sub>out</sub> . Zener regulated voltage output	

#### **BLOCK DIAGRAM**



#### **DEFINITION of TERMS**

I <sub>PTC</sub>	Current flowing through the PTC portion of		
	the circuit		
IFLT	RMS fault current flowing through the diode		
Іоит	Current flowing out the Vout pin of the		
	device		
Trip Event	A condition where the PTC transitions to a		
	high resistance state, thereby significantly		
	limiting IPTC and related currents.		
Trip	Time the PTC portion of the device remains		
Endurance	in a high resistance state.		





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#### **GENERAL SPECIFICATIONS**

Operating Temperature -40° to +85°C Storage Temperature -40° to +85°C

#### ELECTRICAL CHARACTERISTICS<sup>1-3, 11</sup> (Typical unless otherwise specified)

Vz <sup>4</sup> (V)		Izt <sup>4</sup>	I <sub>НОLD</sub> 5 <sup>@</sup> 20⁰	Leakage Current		R Typ <sup>6</sup> (Ohms	R <sub>1Max</sub> <sup>7</sup> (Ohms	V <sub>int</sub> Max <sup>8</sup> (V)		I <sub>FLT</sub> Max <sup>9</sup>		Tripped Power Dissipation 10 Max		
Mi n	Ty p	Max	)	C (A)	Test Voltag e	Max Curren t (mA)	)	)	V <sub>INT</sub> Ma x (V)	Test Curren t (A)	I <sub>FLT</sub> Ma x (A)	Test Voltag e (V)	Valu e (W)	Tes t Volt age (V)
9.6	9.8	10. 0	0. 1	1.3	9.5	5	0.12	0.16	24V	ЗА	+3.5 -40	+24 -16V	1.0	24

Note 1: Electrical characteristics determined at 25°C unless otherwise specified.

Note 2:This device is intended for limited fault protection. Repeated trip events or extended trip endurance can degrade the device and may affect performance to specifications. Performance impact will depend on multiple factors including, but not limited to, voltage, trip current, trip duration, trip cycles, and circuit design. For details or ratings specific to your application contact, Littelfuse Circuit Protection Division directly.

Note 3:Specifications developed using 1.0 ounce 0.045" wide copper traces on dedicated FR4 test boards. Performance in your application may vary.

Note  $4:I_{zt}$  is the current at which  $V_z$  is measured ( $V_z = V_{OUT}$ ). Additional  $V_z$  values are available on request.

Note 5:I<sub>HOLD</sub>: Maximum steady state I<sub>PTC</sub> (current entering or exiting the V<sub>IN</sub> pin of the device) that will not generate a trip even at the specified temperature. Specification assumes I<sub>FLT</sub> (current flowing through the Zener diode) is sufficiently low so as to prevent the diode from acting as a heat source. Testing is conducted with an "open" Zener.

Note 6:R Typ: Resistance between V<sub>IN</sub> and V<sub>OUT</sub> pins during normal operation at room temperature.

Note 7:R<sub>1Max</sub>:The maximum resistance between V<sub>IN</sub> and V<sub>OUT</sub> pins at room temperature, one hour after 1<sup>st</sup> trip or after reflow soldering.

Note 8:V<sub>INT</sub> Max: V<sub>INT</sub> Max relates to the voltage across the PPTC portion of the PolyZen device (V<sub>IN</sub>-V<sub>OUT</sub>). V<sub>INT</sub> Max is defined as the voltage (V<sub>IN</sub>-V<sub>OUT</sub>) at which typical qualification devices (98% devices, 95% confidence) survived at least 100 trip cycles and 24 hours trip endurance at the specified voltage (V<sub>IN</sub>-V<sub>OUT</sub>) and current (I<sub>PTC</sub>). V<sub>INT</sub> Max testing is conducted using a "shorted" load (V<sub>OUT</sub> = 0 V). V<sub>INT</sub> Max is a survivability rating, not a performance rating.

Note 9:IFLT Max: IFLT Max relates to the steady state current flowing through the diode portion of the PolyZen device in a fault condition, prior to a trip event. IFLT Max is defined as the current at which typical qualification devices (12 parts per lot from 3 lots) survived 100 test cycles. RMS fault current above IFLT Max may permanently damage the diode portion of the PolyZen device. Testing is conducted with NO load connected to Vout, such that IOUT = 0. "Test voltage" is defined as the voltage between VIN to GND and includes the PolyZen Diode drop. Specification is dependent on the direction of current flow through the diode. IFLT Max is a survivability rating, not a performance rating.

Note 10:The power dissipated by the device when in the "tripped" state, as measured on Littelfuse test boards (see note 3). Note 11:Specifications based on limited qualification data and subject to change.



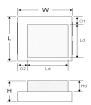
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#### **MECHANICAL DIMENSIONS**



		Min	Typical	Max
Length	1	3.85 mm	4 mm	4.15 mm
Lengin	L	(0.152")	(0.16")	(0.163")
Width	w	3.85 mm	4 mm	4.15 mm
VVIGUI	V V	(0.152")	(0.16")	(0.163")
Height	I н	1.4mm	1.7 mm	2.0 mm
ricigni	''	(0.055")	(0.067")	(0.081")
Length Diode	Ld	_	3.0 mm	_
Longin Diode			(0.118")	
Height Diode	Hd	_	1.0 mm	_
Tioigin Blodd	110		(0.039")	
Offset	01	_	0.6 mm	_
0001			(0.024")	
Offset	02	_	0.7 mm	_
2.1001	J 2		(0.028")	

### **SOLDER REFLOW RECOMMENDATIONS:**

Classification Reflow Profiles						
Profile Feature	Pb-Free Assembly					
Average Ramp-Up Rate (Tsmax to Tp)	3 °C/second max.					
Preheat						
Temperature Min (Tsmin)	150 °C					
Temperature Max (Tsmax)	200 °C					
Time (tsmin to tsmax)	60-180 seconds					
Time maintained above:						
Temperature (TL)	217 °C					
• Time (tL)	60-150 seconds					
Peak/Classification Temperature (Tp)	260 °C					
Time within 5 °C of actual Peak						
Temperature (tp)	20-40 seconds					
Ramp-Down Rate	6 °C/second max.					
Time 25 °C to Peak Temperature	8 minutes max.					

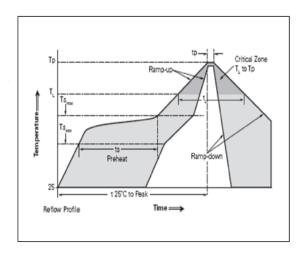


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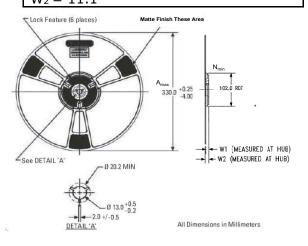


#### **PACKAGING**

Packaging	Tape & Reel	Standard Box
ZENXXXVXXXAXXLS	3,000	15,000

### Reel Dimensions for PolyZen Devices

 $A_{max} = 330$   $N_{min} = 102$   $W_1 = 8.4$   $W_2 = 11.1$ 





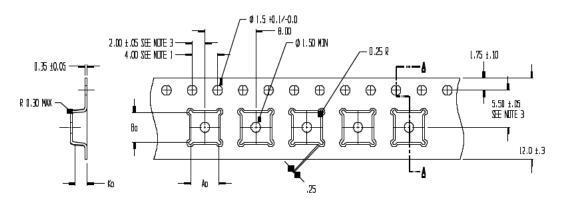
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#### **Taped Component Dimensions for PolyZen Devices**

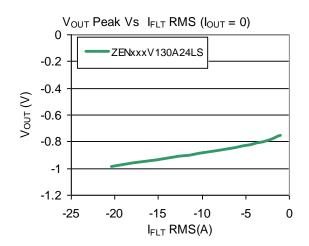


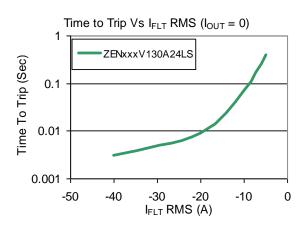
#### NOTES:

1. 10 SPROCKET HOLE PITCH CLMULATIVE TOLERANCE ±0.2

Aa = 4.35 Ba = 4.35 Ka = 2.30 2. CAMBER IN COMPLIANCE VITH EIA 481

3. POCKET POSITION RELATIVE TO SPROCKET HOLE MEASURED AS TRUE POSITION OF POOKET, NOT POCKET HOLE



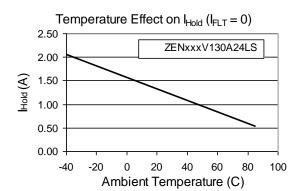


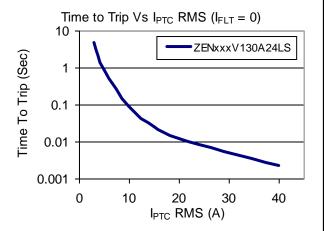


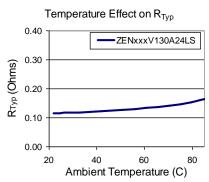
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#### **Materials Information**

**ROHS Compliant** 

Directive 2002/95/EC Compliant **ELV Compliant** 

Directive 2000/53/EC Compliant **Pb-Free** 



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